

Notice of References Cited	Application/Control No. 10/786,609	Applicant(s)/Patent Under Reexamination NAKANO ET AL.	
	Examiner Jennifer T. Nguyen	Art Unit 2629	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,424,328	07-2002	Ino et al.	345/87
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	J	US-			
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FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

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